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Raman Spectroscopy on Semiconductor Nanowires

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1. Introduction

Raman scattering is an inelastic light scattering non-destructive technique which allows the access mainly to the phonon modes at the Γ point of materials and in some cases to the dispersion (Goni A.R. et al., 2001; Zunke et al., 1995; Weinstein et al., 1975). Since its discovery, Raman has been used both for the characterization of materials and for the understanding of basic interactions such as plasmonic excitations (Raman et al., 1928; Szymanski H.A. et al., 1967; Otto et al., 1992; Schuller et al., 1996; Steinbach et al., 1996; Ulrichs et al., 1997, Sood et al. 1985, Abstreiter et al. 1979, Roca et al. 1994, Pinczuk et al. 1977, Pinczuk et al., 1979). Raman spectroscopy can be experimentally performed at the nanoscale by using a confocal microscope or even a tip enhanced scanning microscope. It is possible to obtain lateral submicron resolutions of the properties of a material (Hartschuh et al., 2003). Nowadays Raman spectroscopy is a versatile and relative standard tool for the characterization of materials giving detailed information on crystal structure, phonon dispersion, electronic states, composition, strain and so-on bulk materials, thin film and nanostructures (Cardona, 1982; Anastassakis, 1997; Reithmaier et al., 1990; Spitzer et al., 1994; Pinczuk et al., 1977; Pinczuk et al., 1979; Baumgartner et al., 1984; Schuller et al., 1996; Pauzauskie et al., 2005; Long, 1979).

In the last decade Raman spectroscopy has been increasingly used to study nanowires and quantum dots (Abstreiter et al., 1996; Roca et al., 1994). Several new phenomena have been reported to date with respect to one-dimensional structures. For example, the high surface-to-volume ratio has enabled the measurement of surface phonon modes (Gupta et al., 2003a; Krahn et al. 2006; Adu et al., 2006; Spirkoska et al., 2008). Some authors report an increase in the scattered intensity for nanoscale structures with respect to their bulk counterpart, effect denominated as 'Raman antenna effect' (Xiong et al., 2004; Xiong et al., 2006; Cao et al., 2007). Additionally, polarization dependent experiments on single carbon nanotubes and/or nanowires have shown that the physics behind Raman scattering of such one-dimensional nanostructures can differ significantly from the bulk (Frechette et al., 2006; Livneh et al., 2006; Cao et al., 2006). Indeed, the highly anisotropic shape of the nanowires can lead to angular dependencies of the modes which otherwise would not be expected from selection rules (Frechette et al., 2006; Livneh et al., 2006; Cao et al. 2006).

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Overall, Raman spectroscopy of nanostructures represents an extremely active and exciting field for the benefit of science and technology at the nanoscale. The arising new phenomena and technical possibilities open new avenues for the characterization of materials but also for the understanding of fundamental process in nanoscale matter. In this chapter, we provide a review of Raman spectroscopy on nanowires, in which an overview of the selection rules, appearance of new modes and size effects will be given.

2. Selection rules in Raman scattering of nanowires

2.1 Raman selection rules, application to the geometry of nanowires

Raman scattering is a manifestation of the interaction between the electromagnetic radiation and vibrational and/or rotational motions in a material. It provides information about the symmetry and composition of the system, the lattice dynamics, structural transitions, strain and electronic states. The scattering process involves two energy quanta simultaneously. It is usually schematized in two steps:

- i. A photon with energy $h\nu_o$ and wave vector \vec{q} is absorbed, exciting the system from a initial state 1 to a state n ;
- ii. The system emits a photon with energy $h\nu'$ and wave vector \vec{q}' and relaxes from the state n to a final state 2 .

In the case where the final state is identical to the initial one the incident and scattered light have the same frequency ($\nu' = \nu_o$). This process is called elastic or Rayleigh scattering. When the final state is different from the initial one, the scattering process is inelastic. In this case, the creation or the annihilation of an excited state of the system occurs, and the emitted photon has lost or gained energy. These processes are called respectively Stokes scattering and anti-Stokes Raman scattering. For the conservation of energy, the frequency of the scattered radiation is given by:

$$\nu' = \nu_o \pm \frac{E_1 - E_2}{h} = \nu_o \pm \nu_v \quad (1)$$

with ν_o the frequency of the incoming photon, ν' the frequency of the emitted photon, E_1 and E_2 the energies of the initial and final state of the system. These scattering processes are schematically illustrated in Fig. 1.

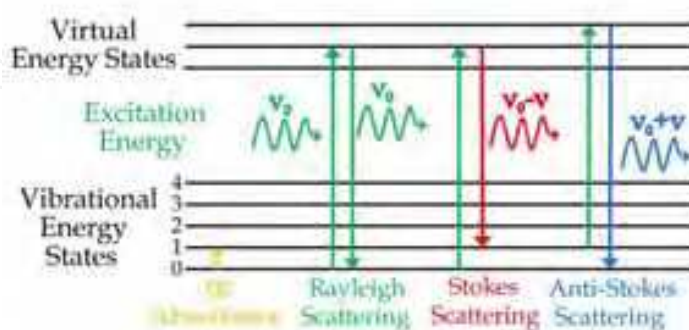


Fig. 1. Schematic drawing of transitions between generic vibrational energy states due to, from left to right, infrared absorbance, Rayleigh Scattering Stokes Raman Scattering and anti-Stokes Raman Scattering.

The difference between the Raman scattering frequency ν' and the excitation frequency ν_0 is independent from the last one and it's equal to $\pm\nu^n$. The probability of the Stokes scattering and the anti-Stokes scattering is different, because of the different population of the two energy levels at a temperature T . The intensity of the Raman lines is proportional to the transition probability. For this reason the Stokes lines are more intense than the anti-Stokes. In the following, a short description of the Raman effect is given within the classical picture (Turrel & Corset, 1996). In this frame, spatial and temporal fluctuations of the electronic contributions of the polarizability are at the origin of the Raman scattering. The electric field originated by a plane monochromatic wave with wave vector \vec{K}_0 in a point \vec{r} in space in a transparent crystal is given by:

$$\vec{E} = E_0 \{ \exp[-2\pi i(\vec{K}_0 \cdot \vec{r} - \nu_0 t)] \} \quad (2)$$

with ν_0 the frequency of the light and t the time. The electric field causes an induced dipole moment given by:

$$\vec{\mu} = \alpha \vec{E} \quad (3)$$

where α is the polarizability. Both $\vec{\mu}$ and \vec{E} are vectors, while α is a 3x3 tensor with real elements, unless magnetic phenomena are involved. The coordinate system and the symmetry of the crystal determine the tensor form. Due to the time dependency of $\vec{\mu}$ and \vec{E} , the induced dipole moment will oscillates in time, with consequent radiation emission. The polarizability can be expanded in as a Taylor series in the normal coordinates $Q_K = Q_K^0 \exp^{-2\pi i[\vec{K}_K \cdot \vec{r} - \nu_K t]}$, with \vec{K}_K the wave vector of lattice wave K . Equation (3) becomes:

$$\vec{\mu} = \alpha_0 E_0 \exp^{-2\pi i(\vec{K}_0 \cdot \vec{r} - \nu_0 t)} + E_0 \sum_K \alpha'_K Q_K \exp^{-2\pi i[(\vec{K}_0 \pm \vec{K}_K) \cdot \vec{r} - (\nu_0 \pm \nu_K) t]} \quad (4)$$

with $\alpha'_K = \left(\frac{\partial \alpha}{\partial Q_K} \right)_0$.

The first term of equation (4) describes the Rayleigh scattering, the oscillation of the induced dipole at the same frequency of the incident light. The second term represents the dipole oscillating at a frequency shifted by the frequency of the normal modes. Therefore, $\nu_0 \pm \nu_K$ is the frequency of the scattered light, which propagates in the direction $\vec{K}_0 \pm \vec{K}_K$.

The Raman scattering is governed by the conservation of energy and by conservation of momentum, which implies that $\vec{K}_0 = \vec{K}_s \pm \vec{K}_K$, being \vec{K}_s the wave vector of the scattered light. Namely, the orientation of the crystallographic axes with respect to the direction and polarization of the scattered light affects the Raman spectrum. In this respect, it is evident that Raman spectroscopy on single crystals gives information about the crystal symmetry. The intensity of the scattered light I_s , which is the scattered energy per unit time, into a solid angle $d\Omega$ is given by:

$$I_s = I_i \cdot k \cdot \left| \hat{e}_i \cdot \vec{R} \cdot \hat{e}_s \right|^2 d\Omega \quad (5)$$

with I_i the irradiance - energy per unit area per unit time - of the excitation incident on the sample, $k = 4\pi^2 \alpha^2 \nu_s^{-4}$, $a \approx 1/137$, ν_s the wavenumber of the scattered light, \hat{e}_i (\hat{e}_s) the

polarization unitary vectors of the incident (scattered) light and \vec{R} the scattering tensors. It is worth to note that the symmetry properties of the polarizability and the scattering tensors are the same. In the case where Raman scattering is realized at the submicron scale, a microscope objective has to be used. For simplicity, a backscattering configuration is preferred. In this configuration the scattered light is collected along the same direction of the excitation, as shown schematically in Fig. 2.

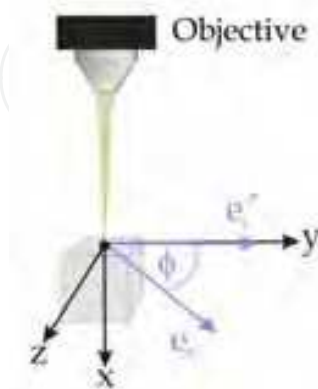


Fig. 2. Schematic drawing of the backscattering geometry. The incoming light is directed along the x direction, with the polarization directed along the y direction. The scattered light is collected along the x direction and its polarization has components along the y and z directions.

As an example, we consider the backscattering geometry with the set of axes as depicted in Fig. 2 and $\hat{e}_i || y$, the Raman intensity is calculated as follows:

$$I_s \propto \left| (010) \begin{pmatrix} R_{xx} & R_{xy} & R_{xz} \\ R_{yx} & R_{yy} & R_{yz} \\ R_{zx} & R_{zy} & R_{zz} \end{pmatrix} \begin{pmatrix} 0 \\ 1 \\ 1 \end{pmatrix} \right|^2 = |R_{yy} + R_{yz}|^2 \quad (6)$$

The use of a determined incident and analyzed polarization in the Raman scattering experiments results in the selection of certain elements of \vec{R} . In this way, polarized Raman spectroscopy enables the determination of the Raman selection rules and the tensor symmetry. In the measurements on a single bulk crystal, it is much more convenient to use the crystallographic axis as a basis and express the polarizability tensor in this basis.

As an example, we consider zinc-blende GaAs. The phonon dispersion is composed of 6 different branches: two transverse and one longitudinal acoustical modes (TA and LA) as well as two transverse and one longitudinal optical modes (TO and LO). The optical photon modes are usually indicated $E_1(\text{TO})$ and $A_1(\text{LO})$. The notation E_1 and A_1 denote respectively to modes vibrating perpendicular and along the z axis. The Raman tensors for zinc blende GaAs are usually given in the base $x = (100)$, $y = (010)$ and $z = (001)$, resulting in:

$$R(x) = \begin{pmatrix} 0 & 0 & 0 \\ 0 & 0 & 1 \\ 0 & 1 & 0 \end{pmatrix}, \quad R(y) = \begin{pmatrix} 0 & 0 & 1 \\ 0 & 0 & 0 \\ 1 & 0 & 0 \end{pmatrix} \quad \text{and} \quad R(z) = \begin{pmatrix} 0 & 1 & 0 \\ 1 & 0 & 0 \\ 0 & 0 & 0 \end{pmatrix} \quad (7)$$

In this set of axes and in backscattering geometry with the direction of excitation and collection perpendicular to a {001} plane, the TO is forbidden while the LO mode is allowed. The intensity of the scattered light polarized along the x or y direction as a function of the angle between the polarization of the excitation and the $x = (100)$ can be calculated using equation (6). The theoretical azimuthal dependence of the intensities is plotted in Fig. 3.

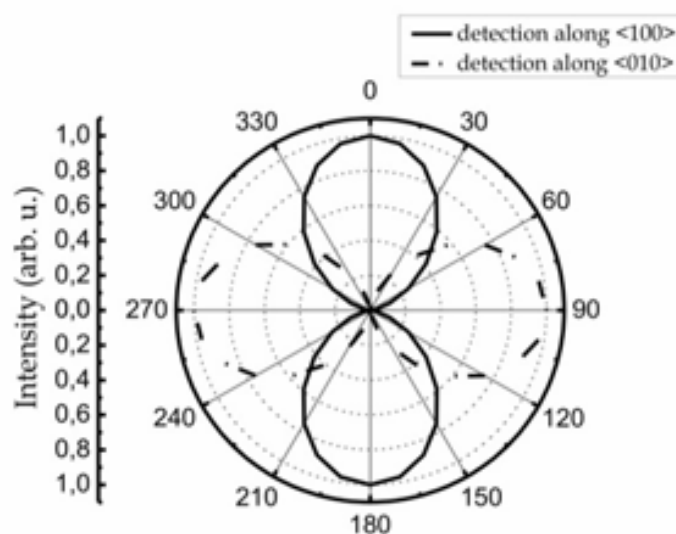


Fig. 3. Theoretical azimuthal dependence of the LO mode of a bulk GaAs (001). Continuous and dashed lines represent the components along the [100] and [010] of the Raman signal, respectively.

The selection rules and the dependency of the intensity on the polarization direction can be calculated even from the other surfaces in the same way. In backscattering geometry both the $A_1(\text{LO})$ or $E_1(\text{TO})$ are observed from the (111) surfaces, while only $E_1(\text{TO})$ is observed from the (110) planes.

If we now consider the geometry of the nanowires, the important crystallographic axis correspond to the directions $x = (0-11)$, $y = (211)$ and $z = (-111)$, which should be used as a basis. A schematic drawing of the relevant axes on a reference bulk sample is shown in Fig. 4a: the x axis corresponds the direction of the incident and scattered light in the [0-11] direction, while y and z are the in plane axes respectively parallel to [211] and [-111]. The selection rules are obtained by transforming the Raman tensor and by expressing the polarization vectors into the new basis and, using eq. (6). The values of the Raman tensor for the transversal modes in that configuration for incident light along the x axis are:

$$R'(y) = \begin{pmatrix} 0 & 1/\sqrt{3} & -1/\sqrt{6} \\ 1/\sqrt{3} & 2/3 & -1/3\sqrt{2} \\ -1/\sqrt{6} & 1/3\sqrt{2} & -2/3 \end{pmatrix}, \quad R'(z) = \begin{pmatrix} 0 & -1/\sqrt{3} & 1/\sqrt{6} \\ -1/\sqrt{3} & 2/3 & 1/3\sqrt{2} \\ 1/\sqrt{6} & 1/3\sqrt{2} & -2/3 \end{pmatrix} \quad (3)$$

The intensity of the scattered light polarized parallel or perpendicular to the [-111] direction, $I_s(\parallel)$ and $I_s(\perp)$, as a function of the angle α between the polarization of the excitation with the [-111] axis is:

$$I_s(\perp) = \left| (0 \quad \sin \alpha \quad \cos \alpha) \left[R'(y) \begin{pmatrix} 0 \\ 1 \\ 0 \end{pmatrix} + R'(z) \begin{pmatrix} 0 \\ 1 \\ 0 \end{pmatrix} \right] \right|^2 = \left| \frac{4}{3} \sin \alpha + \frac{2 \cos \alpha}{3\sqrt{2}} \right|^2 \quad (4)$$

$$I_s(\parallel) = \left| (0 \quad \sin \alpha \quad \cos \alpha) \left[R'(y) \begin{pmatrix} 0 \\ 0 \\ 1 \end{pmatrix} + R'(z) \begin{pmatrix} 0 \\ 0 \\ 1 \end{pmatrix} \right] \right|^2 = \left| \frac{2}{3\sqrt{2}} \sin \alpha + \frac{4}{3} \cos \alpha \right|^2 \quad (5)$$

Fig. 4b and c show the theoretical and experimental dependency of the two components of the scattered light, respectively.

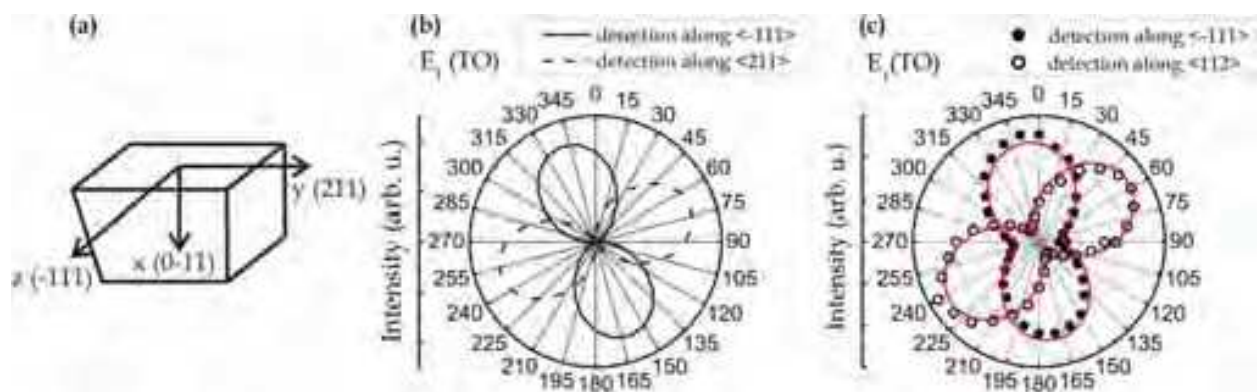


Fig. 4. (a) Crystal facets of the reference used for the measurement of the selection rules in GaAs. The axis correspond to the crystallographic directions: $x=(0-11)$, $y=(211)$ and $z=(-111)$. (b) Theoretical azimuthal dependence of the TO mode of a bulk GaAs (0-11), as in (a). Continuous and dashed lines represent the components along the $[-111]$ and $[211]$ of the Raman signal, respectively. (c) Measured azimuthal dependence of the TO mode of a bulk GaAs (0-11). Diamonds and open circles represent the components along the $[-111]$ and $[211]$ of the Raman signal, respectively. The continuous line is a squared sine fit to the data, which describes polar behaviour.

As mentioned above, this set of axis is the one that should be used for the investigation of single GaAs nanowires with $[111]$ growth axis. For further clarity, a schematic drawing of the nanowire with the corresponding set of axis, as used in Raman backscattering experiment, is presented in Fig. 5a. We studied nanowires presenting a mixture of zinc blende and wurtzite structure. In this case, a further optical mode can be observed at $k=0$, namely the E_2^H (see section 4). Fig. 5b shows representative Raman spectra realized under the main four polarization configurations. The azimuthal dependence of $E_1(\text{TO})$ and E_2^H is presented in Fig. 5c and d. The scattered light has been analyzed selecting the components with polarization parallel - $I_s(\parallel)$ - and perpendicular - $I_s(\perp)$ - to the z axis. The $E_1(\text{TO})$ mode is polarized along the axis of the nanowire. Interestingly, also $I_s(\perp)$ seems to have a slightly higher intensity when the incident light is polarized along the nanowire axis. The scattered light with polarization perpendicular to the z axis, exhibits a drop in the intensity, compared to the measurements on GaAs bulk (Fig. 4c). Indeed, the ratio of intensity between $I_s(\parallel)$ and $I_s(\perp)$ is about 5. Interestingly, the azimuthal dependence of the E_2^H mode associated with the

wurtzite phase exhibits a quite different behavior. In this case the maximum intensity of the scattered light is observed when the incident light is perpendicular to the nanowire axis, both for $I_s(\parallel)$ and $I_s(\perp)$ -though for the latter the dependence is less clear due to the low intensity-.

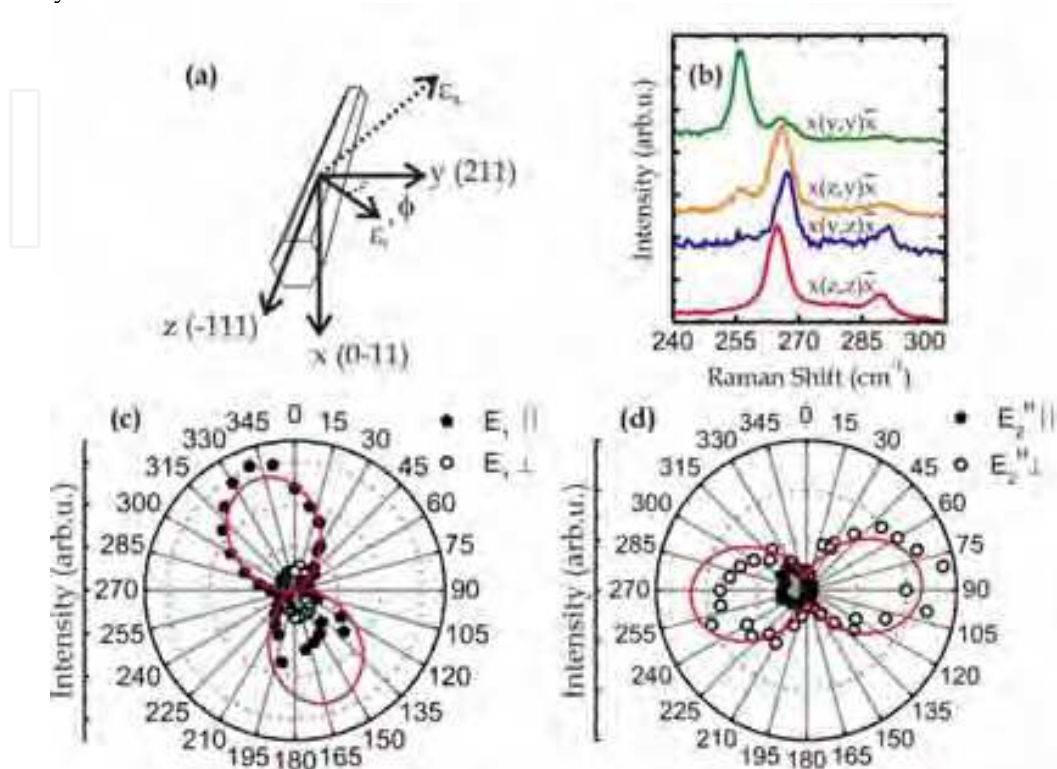


Fig. 5. (a) Sketch of the configurations used for the measurement of GaAs nanowires in backscattering geometry. The crystal facets of the nanowire and the corresponding set of axis used as indicated: $x=(0-11)$, $y=(211)$ and $z=(-111)$. (b) Representative Raman spectra realized under the main four configurations. For better illustration, the spectra have been normalized and shifted vertically. All spectra have been collected in the same position of the nanowire. Azimuthal dependence of the $E_1(\text{TO})$ mode (c) and of the E_2^{H} mode (d), related to the wurtzite structure. Diamonds and open circles represent the parallel and perpendicular components of the Raman signal collected, respectively. The continuous lines are squared sine fit.

→ Effect of the dielectric mismatch

In the case of nanowires, it is worth noticing that there is an enhanced response of the Raman scattering for polarizations along the nanowire axis. As it will be shown in the following, this is partly due to the one-dimensionality and to the small diameter of the nanowires, as it has been reported in literature (Cao et al., 2007; Livneh et al., 2007; Papadimitriou & Nassiopoulou, 1998; Pauzauskie et al., 2005; Duesberg et al., 2006; Fréchette & Carraro, 2006; Cao et al., 2006; Xiong et al., 2006). Xiong et al. found that nanowires with a diameter $d \ll \lambda/4$, with λ the wavelength of the excitation, show a dipolar behavior. Namely, the Raman scattering intensity is $\sim I_0 \cos^2 \alpha$, with I_0 the incident laser intensity and α the angle between the electric field of the laser and the nanowire axis. For larger diameters, $d \gg \lambda/4$, the nanowires present a multipolar character. The authors address the origin of this effect to the scattering of the electromagnetic field from a dielectric cylinder of

nanoscale dimensions. The calculations show that the electric field inside the nanowires with bigger diameter is increased when the electric field of the excitation is either parallel or perpendicular to the nanowire axis. Instead, for smaller diameters, the electric field inside the nanowire is strongly suppressed when the electric field of the excitation is perpendicular to the nanowire axis. Experiments on silicon nanocones showed that the enhancement in the Raman scattering, due to the enhanced internal field, decreases with increasing the nanowires diameter and increases with the wavelength of the excitation, features which suggest a resonant nature (Cao et al., 2006). This enhancement in the Raman scattering is in analogy with absorption, photoluminescence and photocurrent measurements (Cao L., 2009; Wang J. 2009; Thunich S., 2009).

2.2 Appearance of new modes: surface and breathing modes.

Studies comparing Raman scattering experiments of bulk and nanostructured materials have been reported in literature for several different kind of systems. It is usually observed that the transversal optical (TO) and the longitudinal optical (LO) modes have a position in energy close to that observed in bulk. When scaling down the size and the dimensionality of the structures, the position can change (see section 3.1). Additionally, new Raman modes can be found. Effects related to the shape of the system can become significant. The existence of boundary conditions at the nanoscale gives rise to electric and polarization forces. The surfaces represent a new mechanical boundary, since the surface atoms are "less bound" and "feel" a different local field from the bulk. This has consequences even in the propagation of an optical phonon, where the oscillating dipoles - created by the out of phase oscillation of ions and cations - interact by a dipole-dipole interaction. Mahan et al. developed and presented a model which describes the variation of the long range dipolar interactions due to the nanowires geometry, leading to the split of the TO and LO modes in polar semiconductor nanowires (Mahan et al., 2003). Indeed, the highly anisotropic shape of the nanowires determines different contribution in the dipolar sums for the components in the cross sectional plane - x and y - which are truncated by the finite size, from the one along the nanowire growth axis - z -. Accordingly, the local electric field is modified too. The dispersion relation of the optical phonon can be related to the local spring constant (ω_o^2) and to the local electric field (E_μ):

$$\omega^2 q_\mu = \omega_o^2 q_\mu - \frac{e^*}{M} E_\mu \quad (6)$$

where e^* is the Sziget charge and M is the reduced mass of the ion pair. The local field can be expressed as:

$$E_\mu = -T_{\mu\nu} [e^* q_\nu + \alpha E_\nu] \quad (7)$$

with $T_{\mu\nu}$ the components of the dipole-dipole interaction, α the polarizability of the unit cell and αE_ν the induced dipole in the same cell from core polarization. The anisotropy in the dipole sums ($T_{xx} = T_{yy} = \frac{4\pi}{6\nu_o}$ and $T_{zz} = \frac{-4\pi}{3\nu_o}$) for a thin wire with $L \gg R$, with L length and $2R$ diameter of the wire, results into the anisotropy of the dielectric function, whose tensor has now two different components, $\epsilon_{xx} = \epsilon_{yy}$ and ϵ_{zz} , expressed by:

$$\varepsilon_{jj}(\omega) = \varepsilon_{jj}(\infty) \frac{\omega^2 - \omega_{Lj}^2}{\omega^2 - \omega_{Tj}^2}, \quad j = x, z \quad (8)$$

If we consider the optical phonons in a nanowire, equations (6) and (7) can be solved considering the uniaxial geometry, thereby obtaining:

$$\omega_{Lz}^2 = \omega_{LO}^2 = \omega_0^2 + \omega_p^2 \frac{2(\varepsilon_z(\infty) + 2)}{9\varepsilon_z(\infty)} \quad (9)$$

$$\omega_{Tz}^2 = \omega_{TO}^2 = \omega_0^2 - \omega_p^2 \frac{(\varepsilon_z(\infty) + 2)}{9} \quad (10)$$

with $\varepsilon = 1 + \frac{4\pi\alpha/V_o}{1 - 4\pi\alpha/3V_o}$ high frequency dielectric constant and $\omega_p^2 = \frac{4\pi e^{*2}}{MV_o}$ ion plasma frequency, for the z direction, and

$$\omega_{Lx}^2 = \omega_0^2 + \omega_p^2 \frac{(\varepsilon_x(\infty) + 2)}{9(\varepsilon_x(\infty) + 1)} \quad (11)$$

$$\omega_{Tx}^2 = \omega_0^2 + \omega_p^2 \frac{7(\varepsilon_x(\infty) + 2)}{9(\varepsilon_x(\infty) - 1)} \quad (12)$$

with $\varepsilon_x(\infty) = \frac{3\varepsilon_z(\infty) - 1}{\varepsilon_z(\infty) + 1}$ for the other directions. The predicted positions of the triplet arising

from the split of the optical phonon due to the nanowire geometry are very close and therefore not always easily distinguishable. For example, in the case of GaAs or GaP nanowires, the ω_{Lx} and ω_{Tx} modes are about 2 cm⁻¹ shifted from the ω_{Lz} mode (Cao et al., 2007). Nevertheless, an indication of the split can be given by the different position of the LO band in the nanowire spectra respect to the bulk. It has been shown that this shape dependence can explain even the occurrence of an angular dependencies of the phonon modes which otherwise would not be expected from the selection rules (Livneh et al., 2006; Fréchette & Carraro, 2006; Cao et al., 2006).

The reduction in the dimensionality and the presence of edge/boundaries in the crystal can also lead to the appearance/activation in the Raman spectra of inactive Raman modes (silent modes) at the Γ point of the Brillouin zone. This is due to the fact that the symmetry is changed by the existence of the edges, which leads to a rearrangement of the lattice structure. This has been especially observed in nanocrystals (Li et al., 2002; Kawashima & Katagiri, 1999).

Furthermore, there are other size-related phonons appearing when dealing generally with nanostructures, such as the surface optical phonons (SO) and breathing modes. Several works have reported the presence of a further peak in the Raman spectra of semiconductor nanowires or nanoparticles which have been assigned to SO phonons (Gupta et al., 2003a; Shan et al., 2006; Lin et al., 2003; Zeng et al., 2006; Spirkoska et al., 2008). The surface optical phonons are generated at the interface between different materials with different dielectric functions and propagate along the interface. The atoms involved in their propagation are

those close to the surface, so that the amplitude of the oscillations decays exponentially with the distance from the surface. This mode is activated by a breaking of the translational symmetry of the surface potential, which in the case of the nanowire can be addressed to the presence of roughness, sawtooth faceting on the nanowire sidewall or to a diameter oscillation along the nanowire length.

There are two characteristics which are distinctive of the SO modes and can therefore allow a reliable assignment of the mode: the dependence of the position (1) on the dielectric constant of the medium surrounding the wires and (2) on the diameter (or on the period of the diameter oscillation) of the wires. Indeed, it has already been shown that the SO mode position down shift increasing the dielectric constant of the surrounding optical medium and decreasing the nanowire diameter (Shan et al., 2006; Adu et al., 2006a; Spirkoska et al., 2008). Furthermore, the frequency of the SO modes at the center of the Brillouin zone is located between those of the TO and the LO.

The SO modes dispersion at the interface between a semiconductor and a dielectric material can be calculated imposing the condition:

$$\varepsilon(\omega) + \varepsilon_m = 0 \quad (13)$$

with $\varepsilon(\omega)$ the dielectric function of the semiconductor and ε_m the dielectric constant of the medium. In the case of an infinitely long cylinder equation (13) becomes:

$$\varepsilon(\omega) + \varepsilon_m f(qr) = 0 \quad (14)$$

where $f(qr)$ is given by

$$f(qr) = \frac{I_0(qr)K_1(qr)}{I_1(qr)K_0(qr)} \quad (15)$$

With q the phonon wavevector, r the nanowire radius and $I_i(qr)$ and $K_j(qr)$ the modified Bessel functions. Indeed, the dispersion relation for a SO mode for an infinitely long cylinder can be expressed by:

$$\omega_{SO}^2(q) = \omega_{TO}^2 + \frac{\tilde{\omega}_p^2}{\varepsilon_\infty + \varepsilon_m f(qr)} \quad (16)$$

with ω_{TO} the TO mode frequency, $\tilde{\omega}_p$ the screened ion plasma frequency given by $\tilde{\omega}_p^2 = \varepsilon_\infty(\omega_{LO}^2 - \omega_{TO}^2)$, ε_∞ the high frequency dielectric constant of the bulk material, ε_m the dielectric constant of the surrounding medium. Equation (16) establishes, therefore, the dependency of the surface phonon energy on the external medium and on the size of the wire, since the position of the surface optical phonon can be related to the dielectric constant of the surrounding medium as well as to the nanowire radius. Furthermore, values of q for the activation of the SO mode can be determined experimentally (Gupta et al., 2003a). Instead, the line width of the surface mode has not been yet well understood.

The effect of the position of the SO modes can be clearly observed by comparing semiconductor nanowires with various diameters. As an example, we show the Raman

spectra of GaAs nanowires of diameters 160 and 69 nm in Fig. 6a. For the nanowire with the largest diameter, the SO mode is barely observed as the position is very close to the LO phonon. As expected, the SO mode shifts to lower wavenumbers for smaller diameters, as it can be seen in the spectra obtained for nanowires with an average diameter of 69 nm. The entire trend of the position as a function of the diameter is shown in Fig. 6b. There, the line indicates what would be expected for nanowires with a circular section—GaAs nanowires exhibit a hexagonal section, which explains the discrepancy with the experimental data. More details on the experiments can be found elsewhere (Spirkoska et al., 2008).

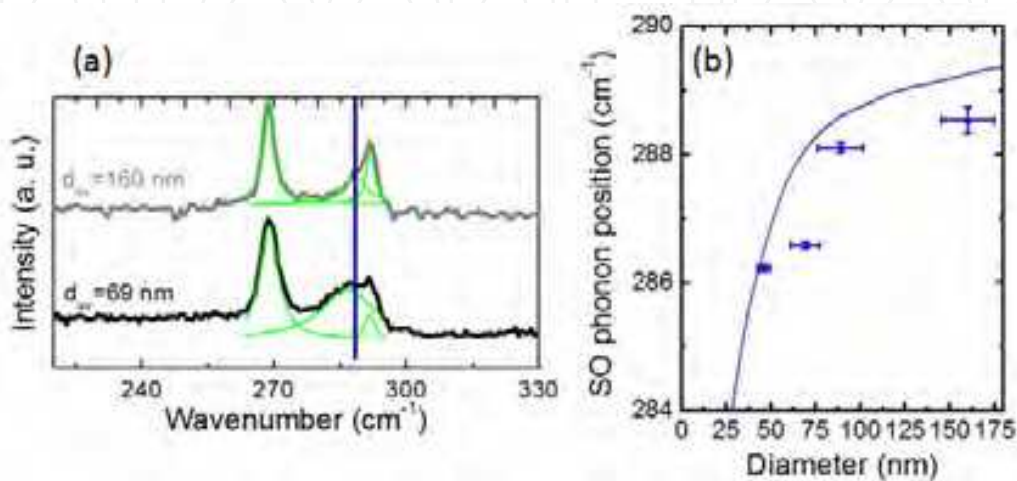


Fig. 6. a) Raman spectra of GaAs nanowire bundles with respectively an average diameter of 160 and 60 nm. The SO mode can be observed on the left of the LO mode b) Evolution of the SO phonon position as a function of the diameter of the nanowires. The line corresponds to the theoretical values expected for cylindrical GaAs nanowires.

Indeed, it has been proved that the cross section of the nanowires influences the surface mode dispersion (Adu et al., 2006a; Xiong et al., 2006). In these works, a model for nanowire with rectangular cross section has been developed. By setting z as growth direction and defining L_i ($i = x, y$) the edges of the rectangular cross section, the SO dispersion can be found solving the equations:

$$\varepsilon_{nw}(\omega) \tanh\left(\frac{q_i L_i}{2}\right) + \varepsilon_m = 0 \quad (17a)$$

$$\varepsilon_{nw}(\omega) \coth\left(\frac{q_i L_i}{2}\right) + \varepsilon_m = 0 \quad (17b)$$

where q_i ($i = x, y$) is the phonon wavevector of the modes propagating along x or y , which are the directions affected by the size effects, assuming the wire infinitely long along the z direction. Equation (17a) gives the symmetric mode, while equation (17b) the asymmetric one. Two more conditions have to be fulfilled:

$$q_x^2 + q_y^2 = q^2 \quad (18a)$$

$$q_x L_x = q_y L_y \quad (18b)$$

the latter one imposing the same parity to the optical phonon potential in the x and y directions. The symmetric and asymmetric SO phonon dispersion can then be expressed by:

$$\omega_{SO\ S}^2(q) = \omega_{TO}^2 \frac{\varepsilon_o \tanh\left(\frac{q_i L_i}{2}\right) + \varepsilon_m}{\varepsilon_\infty \tanh\left(\frac{q_i L_i}{2}\right) + \varepsilon_m} \quad (19a)$$

$$\omega_{SO\ A}^2(q) = \omega_{TO}^2 \frac{\varepsilon_o \coth h\left(\frac{q_i L_i}{2}\right) + \varepsilon_m}{\varepsilon_\infty \coth\left(\frac{q_i L_i}{2}\right) + \varepsilon_m} \quad (19b)$$

The comparison between equations 16 and 19 for the circular and rectangular sections leads to the conclusion that both the shape and size of the cross section have an important influence on the position of the SO phonon.

Beside the surface modes, it is worth shortly mentioning another mode found in nanowires which cannot be observed in bulk materials: the Radial Breathing Mode (RBM). This mode was first observed in carbon nanotubes, corresponding to the atomic vibration of the carbon atoms in the radial direction. Its frequency was found to be highly dependent on the nanotubes diameter (Alvarez et al., 2000; Jorio et al., 2003; Maultzsch et al., 2005). The same mode has been observed even in semiconductor nanowires (Thonhauser & Mahan, 2005; Lange et al., 2008), and in both cases the inverse dependence on the nanowire diameter has been found. Assuming the nanowire as an infinitely long isotropic cylinder, the linear elasticity theory furnishes an expression of the RBM:

$$\omega = \frac{2\tau_n}{d} \sqrt{\frac{E(1-\nu)}{\rho(1+\nu)(1-2\nu)}} \quad (17)$$

with ν the Poisson's ratio, ρ the nanowire specimen density, E the Young's modulus of the nanowire material and τ_n given by $\sqrt{\tau J_0(\tau)} = \sqrt{\frac{(1-2\nu)}{(1-\nu)}} J_1(\tau)$ where J_i are the Bessel functions. Equation (14) establishes the $1/d$ dependence of the radial mode frequency, being all the other terms dependent only on the material properties.

3. Confinement, heating effects and Fano resonance scattering

3.1 Phonon quantum confinement in nanowires

Some of the novel fundamental properties found in nanostructures are related to carrier and phonon confinement (Fischer et al., 2006; De Franceschi et al., 2003; Wanwees et al., 1988; Samuelson et al., 2004; Hu et al., 2007; Shorubalko et al., 2008; Rao et al., 1997; Bawendi et al., 1990; Lehmann et al., 1991). Confinement is usually correlated with tailoring novel physical properties, often giving rise to novel applications (Faist et al., 1994; Somers et al., 2008; Steckel et al., 2003). Raman spectroscopy is an ideal and relatively straightforward technique to test quantum confinement. Moreover, it can be realized under many extreme and non-

extreme conditions, leading to an ideal technique for the investigation of processes in matter at low/high temperatures and/or high pressures (Iwasa et al., 2004; Kim et al., 1996; Wright et al., 1997; Weinstein et al., 1975; Congeduti et al., 2001). Indeed, phonon scattering in crystals of small dimension leads to a redshift and broadening of the first order Raman line. This is due to the relaxation of the $q=0$ selection rule when the volume objects becomes of the order of few phonon wavelengths. For nanoscale object such as nanocrystals or nanowires, the exact shape of the Raman peak becomes a convolution of the dispersion relation of phonons in the material (Richter et al., 1981; Campbell et al., 1986). Such effect was initially observed in nanocrystals and more recently in nanowires (Fauchet et al., 1988; Adu et al., 2006a; Jalilian et al., 2006; Fukata et al., 2006). In the particular case of nanowires, the confinement occurs in the diameter direction. It has been predicted and experimentally confirmed that the Raman scattering intensity $I_s(\omega, d)$ for a diameter d at a photon frequency ω relative to the laser frequency is given by (Campbell et al., 1986):

$$I_s(\omega, d) = I_o \cdot \int_0^1 2\pi q_{\perp} \cdot dq_{\perp} \cdot \frac{|C(q_{\perp})|^2}{(\omega - \omega_o(q_{\perp}, T))^2 + \Gamma(T)^2/4} \quad (18)$$

Where $|C(q_{\perp})|^2 \propto \exp(-\alpha a_0/\sqrt{2} \cdot q_{\perp} d)$ is the confinement function, a_0 the lattice constant of the material, α a material dependent constant, q_{\perp} is the phonon wave vector in perpendicular to the nanowire axis, $1/\Gamma$ the phonon lifetime. In the case where Raman spectroscopy is realized on nanowire pads ensembles, it is essential to take into account of the nanowire diameter distribution for the exact modeling of the experimental curves (Adu et al., 2005). These observations extend to most of materials systems from silicon, germanium, zinc oxide, gallium phosphide, zinc sulfide... Equation (18) suggests that reducing the diameter of a cylindrical nanowire results in a redshift (towards lower frequencies) and a broadening of the Raman line. The exact shape of the spectrum is given by the equation and it would vary for other types of geometry, such as spherical or cubical nanoparticles or cylindrical or prismatic nanowires. In the case of silicon, a maximum shift of 8 cm^{-1} is observed for 4 nm nanowires (Adu et al., 2005).

In the following, we present an example of spatially resolved Raman spectroscopy measurements, indicating regions of the nanowire where the functional material achieves nanometer dimensions. Thereby, it helps to predict if it will be possible to obtain functional electronic devices with the nanowires. The samples consisted of germanium nanowires grown by chemical vapor deposition by using indium as a catalyst, the details reported elsewhere (Xiang et al., 2009). Structural analysis of the nanowires evidenced that they consisted in a crystalline core, surrounded by an amorphous shell, as shown in Fig.7a. Interestingly, it was shown that the crystalline core was not continuous along the nanowire and that it could shrink down to $\sim 10 \text{ nm}$ in diameter –see Fig. 7b-. The shrinking of the core poses many problems if these nanowires are to be used for electronic devices, as they will inevitably be short-circuited. A non-destructive diagnosis such as Raman can provide the information on what regions of the nanowire can be used for the devices. For that, it is necessary to realize scanning Raman spectroscopy measurements along the whole length of the nanowire. An example is shown in Fig. 7c. There, 100 nm spaced Raman spectra along

an 86 nm wide germanium nanowire are shown –the diameter was obtained by measuring the height in an Atomic Force Microscope scan-. In the measurements, only the peak corresponding to the TO/LO phonon mode of crystalline germanium is observed. In the small diameter nanowires we do not observe the contribution of the amorphous band. This could be due to various effects: 1) due to the small diameter, the fraction of amorphous germanium is significantly smaller than for a nanowire with larger diameter 2) the density of the amorphous shell is smaller than that of the crystalline core. For reference, we have plotted the position of the unstrained germanium. Along the 2 μm of the scan, a recurrent shift towards lower frequencies is observed. The shift can be attributed to the phonon confinement in the core of the nanowire. The data fit well with the model in which the nanowire is assumed to have a spherical nanocrystal shaper shape. According to this, the observed downshift of 6 cm^{-1} corresponds to a diameter smaller than 30 nm. The spatially resolved Raman scattering measurements indicate a variation of the core diameter along the nanowire, which are in agreement with the transmission electron micrographs realized.

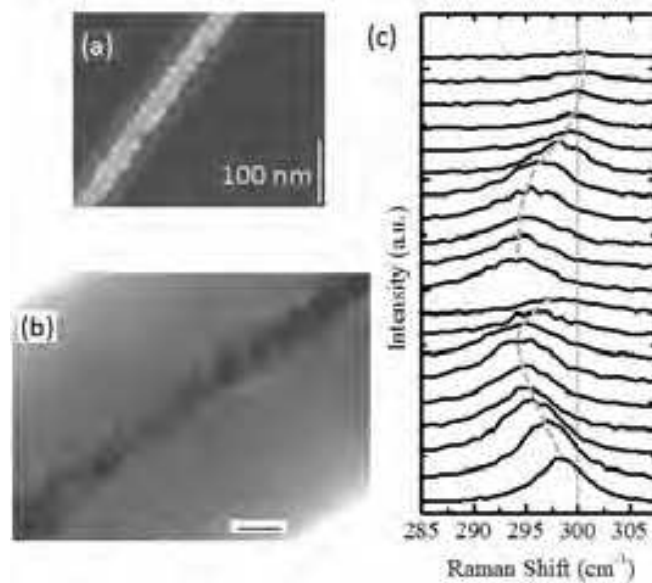


Fig. 7. a) Scanning TEM annular dark field micrograph obtained in one part of a 10 micron long germanium nanowire, showing a 40 nm multi-crystalline core, capped with a 21 nm thick amorphous layer b) Bright field TEM micrograph of a part of a germanium nanowire where the crystalline core is 5 nm. The amorphous shell is 40 nm thick, c) Waterfall plot of Raman spectra taken every 100 nm of a thin nanowire. As a guide to the eye, the light grey line indicates the position of the TO/LO unstrained Ge mode, and the thick dashed line indicates the position of the Raman mode in the nanowire.

Relatively recent studies have shown that one should be very cautious in the analysis of quantum confinement measurements (Campbell et al., 1986; Fauchet et al., 1988). Indeed, note that in the eq. (18) the phonon frequency $\omega_0(q_{\perp})$ and the phonon lifetime $1/\Gamma$ are a function of temperature. One should also note that the radiation power density incident on the nanowire increases dramatically for small diameter nanowires. Indeed, for equal diameter spot the volume of sample illuminated is proportional to d^2 . As a consequence, the power density received by the sample is proportional to $1/d^2$. This immediately points

out the possibility of inevitable heating in the case of extremely small diameter nanowires (the ones expected to exhibit quantum confinement). Additionally, high excitation power densities create a high density of free carriers. This is especially true for indirect bandgap semiconductors such as silicon which exhibit long recombination times. The carriers can also interfere with the phonons giving rise to Fano phenomenon and create an asymmetric line shape (Compaan et al., 1985). In the next sections we discuss these effects on the shape of the Raman spectra.

3.2 Heating effects during Raman spectroscopy measurements

A typical effect of laser irradiation on nanoscale samples is heating. This effect is amplified due to the relative increase in the power density, consequence of the sample geometry. It is also a consequence of the lower thermal conductivity of nanowires and of thermal insulation between the nanoscale object –e.g. nanowire- and the substrate (Li et al., 2003). The usual way to increase the temperature of samples during Raman spectroscopy measurements is to increase the incident irradiation power. An example of the effect on heating on the Raman spectrum is shown in Fig. 8. There, Raman spectroscopy measurements of a single GaAs nanowire as a function of the incident power density are shown. Clearly, both the TO and the LO modes become increasingly asymmetric as the incident power density is increased. A shift of the peak position towards lower wavenumbers is also clear. Between the two effects, the asymmetric broadening is the first one that arises. This tendency can be clearly seen in the graph of Fig. 8b, where the evolution of the peak position and FWHM is shown for each excitation power.

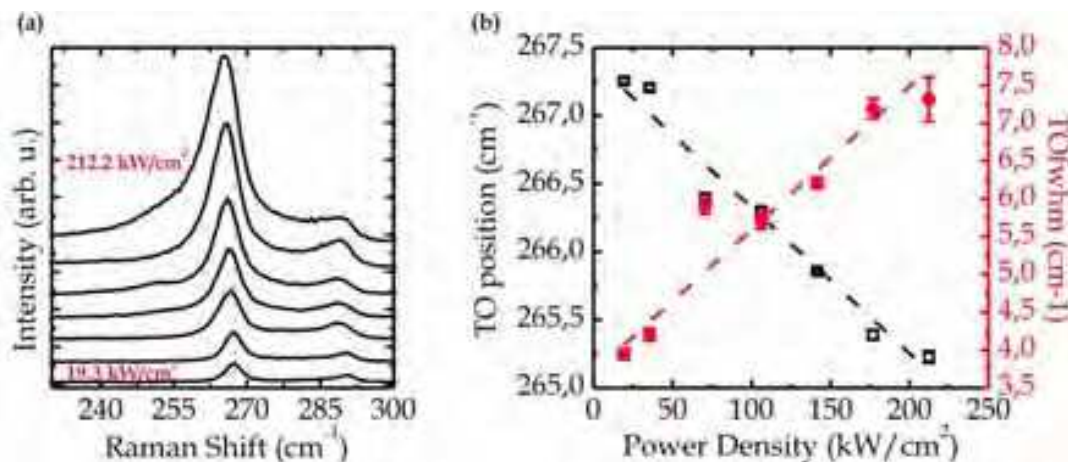


Fig. 8. Raman spectra of zinc-blende GaAs nanowire bundles collected increasing the power density from 19.3 till 212.2 kW/cm². b) Position and FWHM of the TO mode of the spectra shown in a), as a function of the power density. The dashed lines are linear fit to the data.

The temperature of the nanowire T upon laser heating is usually estimated by calculating the ratio of the integrated intensity between the Stokes and Anti-Stokes peaks $-I_S$ and I_{AS} at the phonon frequency ω_o , which is (Balkanski et al., 1983):

$$\frac{I_S}{I_{AS}} = \exp\left(\frac{\hbar\omega_o}{KT}\right) \quad (19)$$

In the case of homogeneous heating of a material, the effect of temperature on the Raman line shape is due to: 1) the decrease in the phonon frequencies ω_o because of thermal

expansion and 2) to the increase in the inverse optical phonon lifetime $1/\Gamma$ for $q=0$ (Balkanski et al., 1983). For a uniform heating, the effect of temperature increase should homogeneously broaden and shift the Raman line. However, experimentally an asymmetric broadening is always observed (Jalilian et al., 2006; Piskanec et al., 2003). This observation can only be explained by the existence of temperature gradients along the nanowire. Indeed, one should consider the laser intensity distribution $I(z) = I_0 e^{(-z/a)}$ - Gaussian- and the induced temperature response $T(z)$ due to the thermal conductivity and capacity of the nanowire. Then, equation 18 is transformed in the following expression for the description of the line shape function (Adu et al. 2006b):

$$I(\omega) = \int_{-c}^c dz I_0 e^{(-z/a)} \int_0^1 2\pi q_{\perp} dq_{\perp} \cdot \frac{|C(q_{\perp})|^2}{(\omega - \omega_0(q_{\perp}, T))^2 + \Gamma(T)^2/4} \quad (20)$$

It has been demonstrated that the use of this equation for the fitting of the Raman spectra is essential to decouple the effect of thermal heating and confinement (Adu et al., 2006a, Adu et al., 2006b).

An additional consequence of the heating may be structural phase transformation. Indeed, other crystalline structures may be rendered stables at higher temperatures. This phenomenon may be accentuated by the geometry of nanoscale objects, which exhibit a much larger surface-to-volume ratio (Wickham et al., 2000). As an example, we have investigated the evolution of Raman spectra of silicon nanowires with hexagonal structure after heating them with the excitation laser -the measurements were realized at room temperature-. The hexagonal or lonsdaleite structure is a metastable phase of silicon under normal conditions, also denominated as Si-IV. It has been reported by several authors in the form of nanowires (Fontcuberta i Morral et al., 2007; Lopez et al., 2009; Arbiol et al.; 2008). Being Si-IV a metastable phase, it is expected that it may transform into diamond structure (Si-I) upon heating. In Fig. 9, the spectra of an ensemble of silicon nanowires exhibiting the Si-IV phase is shown. The Raman spectra after three annealing treatments of 200s at 60, 100 and 140 kW/cm² are also shown. The Raman spectra at the end of the irradiation are fitted to obtain the temperature, which corresponds to 200, 440 and 600°C. After the first

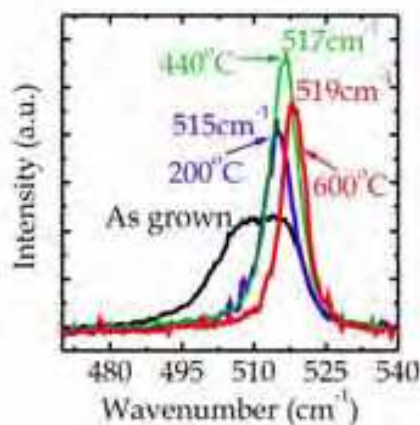


Fig. 9. Raman spectra of Si-IV nanowire bundles as grown and after heating them by illumination with the Raman objective at temperatures of 1) 200°C 2) 440°C and 3) 600°C.

treatment, the Raman peak related to the Si-IV phase disappears completely, and a new unique peak at 515cm^{-1} appears. By successive annealing, the peak shifts to 517 and 519cm^{-1} . This indicates that the sample structure continues to consist in diamond silicon. Additionally, the correlation length of the phonons increases, in agreement with the TEM results showing an improvement in the crystalline structure -increase in grain size- (Prades et al., 2007).

3.3 Fano resonant scattering

Finally, we address another effect resulting from the use of high excitation power densities in Raman scattering experiment. High excitation power densities create a high density of free carriers, which can interfere with the phonon scattering. Fano interference in Raman scattering has been extensively studied in highly doped bulk silicon samples (Belitsky et al., 1997; Arya et al., 1979). It results in an asymmetric line shape of the first order phonon Raman peak, following the equation (Madidson et al., 2002):

$$I(\omega) = C + \sigma_o \frac{(q + \varepsilon)^2}{1 + \varepsilon^2} \quad \varepsilon = \frac{\omega - \omega_o}{\Gamma} \quad (21, 22)$$

Where ω is the scattered photon energy, ω_o and Γ are respectively the resonance frequency and width, and σ_o and C are constants. The influence of Fano scattering on the Raman spectra is determined by q , the asymmetry parameter. In fact, it has been generally found in bulk silicon that $1/q$ is proportional to the free carrier concentration. The curve becomes Lorentzian for $q \rightarrow \infty$ and the asymmetry increases as the value gets smaller. In Fig. 10, we have plotted the shape of the Raman peak of germanium for different values of q . There, it is clear that values of q of 10 start to be enough to create an asymmetry in the Raman spectrum. Experimentally, values of q between 35 and 4 have been measured for highly doped p-type bulk silicon samples (Madidson et al., 2002). In the case of undoped silicon nanowires, values of 8 and 17 have been reported (Gupta et al., 2003b). These studies have demonstrated that taking into account the effect of Fano interference, when fitting the measured Raman spectra. Indeed, Raman scattering of small diameter nanowires is not a straightforward measurement. Effects like quantum confinement, diameter distribution, inhomogeneous heating and Fano interference have to be taken into account correctly for the accurate interpretation.

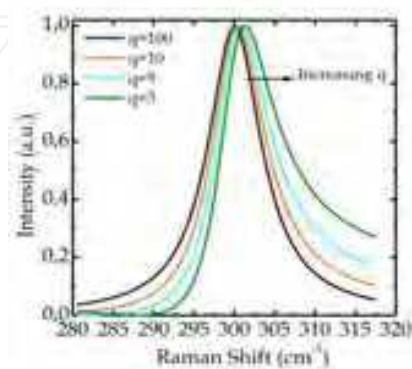


Fig. 10. Illustration of the effect of decreasing q in the asymmetry of one phonon Raman spectra of germanium –calculations following eq. 21).

4. Existence of different crystallographic phases in a nanowire: Study of GaAs nanowires with wurtzite/zinc-blende structures

Most of the binary octet semiconductors such as GaN and SiC present either zinc-blende or wurtzite structure, which correspond to the cubic and hexagonal structure with two atoms per basis. From the crystallographic point, the two structures differ only in the stacking periodicity of the atomic layers along the c-axis of the hexagonal structure. The stacking sequence is 'abcabc' for the cubic structure and 'abab' for the hexagonal one, as shown in Fig. 11 (Park et al., 1994).

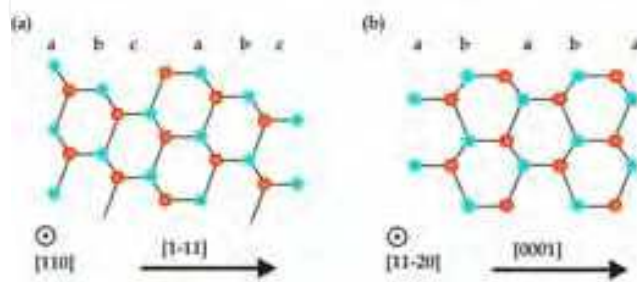


Fig. 11. Schematic drawing of the atomic arrangement in zinc-blende (a) and wurtzite (b) structures. The arrows indicate the $[1-11]$ and the $[0001]$ nanowire growth axes, respectively.

The spectroscopic, electronic and thermal conductivity properties of these two structures and of their polytypisms can be very different (Yeh et al., 1992). Especially interesting are structures formed by the two crystallographic phases, a sort of homo-heterostructure, which exhibit novel optical and electronic properties (Spirkoska et al., 2009). Controlled reproduction of polytypisms in materials give new degrees of freedom in the realization of electronic devices and in the structural bandgap engineering (Raffy et al., 2002; Algra et al., 2008; Mishra et al., 2007; Arbiol et al. 2009).

The different stacking order of the planes implies different symmetry groups. This, together with the slightly different lattice parameter should lead to different vibrational properties. Nevertheless - as it has been shown in the case of GaN, SiC and Si - the phonon dispersion of hexagonal structure can be deduced with good accuracy from the phonon dispersion of the cubic one by just considering the different stacking of the 'abc' and 'ab' layers (Harima, 2002; Loudon, 2001; Kobliska & Solin, 1973). The phonon dispersion of the cubic structure along the $[111]$ direction corresponds to the $\Gamma \rightarrow L$ direction in the Brillouin zone. For clarity, we remind that the c axis of the hexagonal structure can be indexed in the 4 index Miller notation as $[0001]$, and it is equivalent to the $[111]$ axis of the cubic structure. The unit cell length along the $[0001]$ axis of the hexagonal structure is double than that of the cubic structure along the $[111]$ direction, since they correspond to the width of two and one bilayer, respectively. Consequently, the phonon dispersion of the hexagonal structure along the $[0001]$ axis can be approximated by folding the one of the cubic structure along the $[111]$ axis, as shown in Fig. 12 for the cases of GaN, GaAs and Si (Harima, 2002; Zardo, 2009b; Giannozzi, 1991).

As a consequence of the folding, the phonon modes at the L point are taken back at the Γ point of the Brillouin zone, giving rise to four new modes. As an example, in the case of GaAs we have the appearance of the E_2 and B_1 modes in the optical branches. In backscattering geometry Raman spectroscopy only the E_2 mode can be observed and it should be located at lower frequencies than the $E_1(\text{TO})$ mode. For silicon, a new optical branch appears down from the degenerate TO/LO one. One expects to observe a novel vibrational mode around $\sim 500 \text{ cm}^{-1}$, 20 cm^{-1} below the $q = 0$ TO/LO mode.

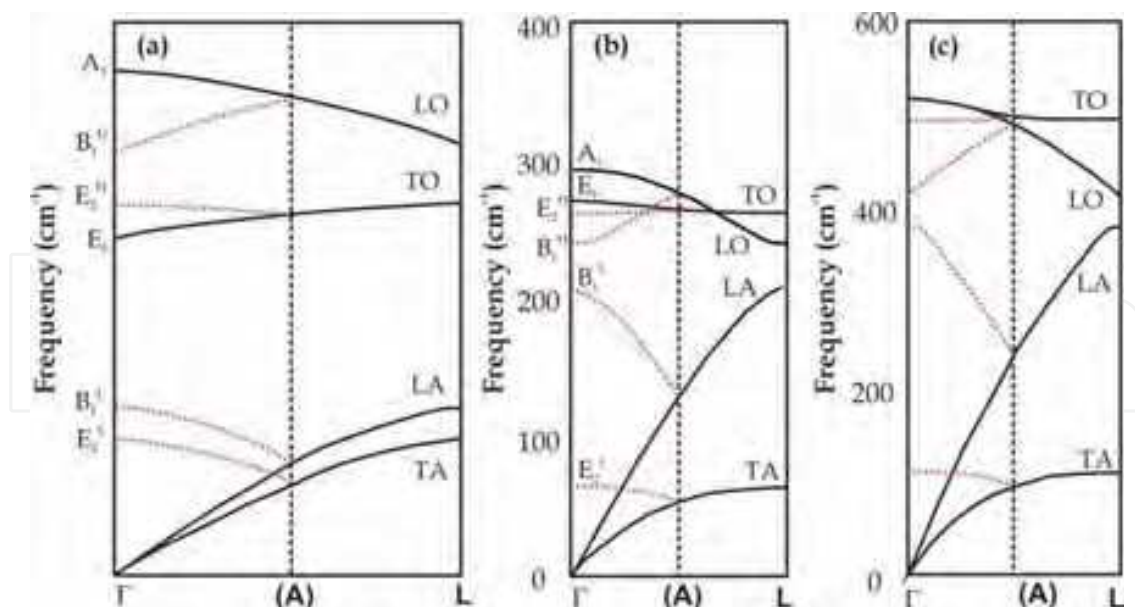


Fig. 12. Schematic representation of the phonon dispersion in GaN (a), GaAs (b) and Si (c). Phonon branches along [111] in the zinc-blende structure are folded to approximate those of wurtzite structure along [0001].

In this context, even the incidence of stacking faults and twins in nanowires gains attention and it is currently under deep investigation (Bandet et al., 2002; Lopez et al., 2009; Algra et al., 2008; Caroff et al., 2009; Zardo et al., 2009a; Conesa-Boj et al., 2009; Arbiol et al., 2009; Spirkoska et al., 2009). Indeed, the atomic stacking can be altered locally from a rotationally twin plane, so that when it occurs in a cubic nanowire gives rise to the occurrence of a monolayer of the hexagonal phase (Arbiol et al., 2009). Furthermore, twins can also cross or exist in high density, resulting into the formation of different structures, localized superstructures or heterostructure phase domains. For example, twinning superlattices are formed whenever twins occur with a certain periodicity. Additionally, the intersection of transversal and lateral twins (twins respectively along or with an angle with the growth axis) can lead to the formation of nanoscale domains with diamond hexagonal phase in the typical silicon cubic structure (Conesa-Boj et al., 2009). As already mentioned above, one should keep in mind that even their polytypisms can have very different physical properties from the pure crystalline phases (Lopez et al., 2009). As it will be shown in the following, Raman spectroscopy is a versatile technique that helps identify materials and areas in the materials with different crystal structures and/or polytypisms. The correlation with Transmission Electron Microscopy measurements can sustain and complement the information.

As an example, we show the case of GaAs nanowires with crystalline structures not stable in the bulk. The stable crystal structure for bulk GaAs is the zinc-blende. However, it has been shown GaAs nanowires can crystallize in the wurtzite structure, as shown in Fig. 13.

Fig. 14 contains an intensity map of the polarization dependent Raman spectra measured with a spacing of 100 nm along the nanowire. The incident and analyzed polarization are parallel respect to each other, and both perpendicular (Fig.14a) or parallel (Fig. 14b) to the nanowire growth axis z .

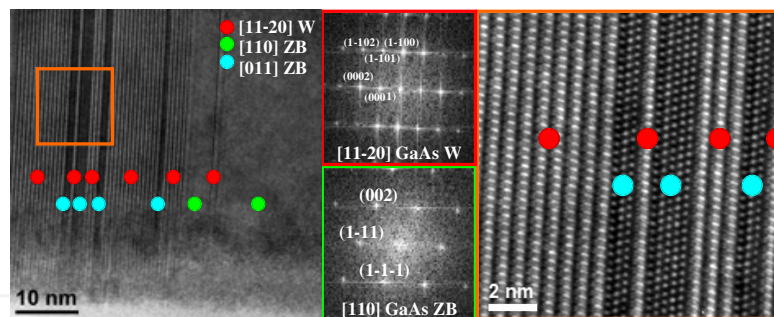


Fig. 13. HRTEM micrographs and power spectra analyses corresponding to GaAs NWs from a sample showing high content of Wurtzite and ZB regions with few monolayers.

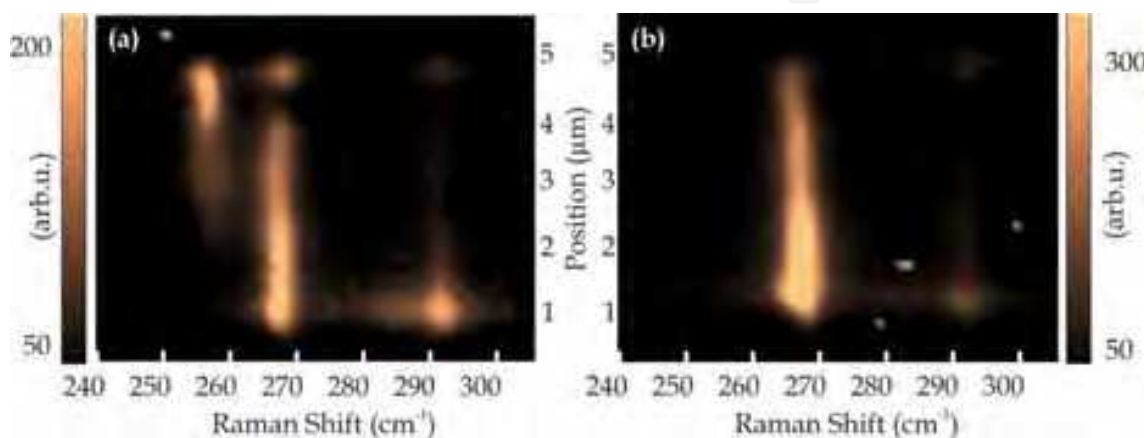


Fig. 14. Color plots showing polarized Raman scans from a nanowire consisting of 30% of wurtzite structure, obtained using different polarization direction of the incident light: a) Perpendicularly polarized Raman scan from perpendicularly polarized incident light: $x(y,y)\bar{x}$ b) parallel polarized Raman scan from parallel polarized incident light: $x(z,z)\bar{x}$.

The E_1^H (TO) mode is observable for both polarization configurations at 266.7 cm^{-1} , as expected for GaAs nanowire. When the polarization of the incident light is perpendicular to the nanowire axis, a further peak appears. This peak is positioned at about 256 cm^{-1} , which corresponds to the E_2^H (TO) mode from the wurtzite GaAs phase, as a result of the folding of the E_1 (TO) branch of the phonon dispersion in the zinc blende structure, as illustrated above. The E_2^H (TO) mode intensity is higher at one end of the nanowire and decreases towards the middle, in good agreement with the percentage of wurtzite phase in the nanowire. Furthermore, in confirmation of the assignment of this peak to the E_2^H (TO) mode of the wurtzite structure, its dependence on the polarization of the excitation follows the Raman selection rules (see Fig. 5).

Another interesting feature of the measurements presented in Fig. 14 is the presence of the A_1 (LO) mode. Even though the A_1 (LO) mode is not allowed for the backscattering configuration on $\{110\}$ family surfaces, to which the nanowires side facets belong, it is weakly present at 290.9 cm^{-1} at one end of the nanowire. Its presence is related to the occurrence of highly dense twins in the zinc blende crystal structure, which cause that the facets of the nanowire are not of the family $\{110\}$ anymore, but $\{111\}$. The A_1 (LO) mode is allowed for backscattering from $\{111\}$. The small $\{111\}$ faceting at the end of the nanowire can explain the increased intensity of the A_1 (LO) phonon mode.

As a further example, we present Raman spectroscopy measurements on nanowires with a relatively high density of twins. Indeed, Raman spectroscopy is extremely sensitive even to structural defects such as the presence of dense stacking faults or twins (Lopez, 2009). Fig. 15 shows Raman spectra from silicon nanowires grown using Indium as catalyst. The nanowires present the [112] growth direction with very high density of twin defects along the {111} planes and consequent formation of hexagonal domain. In addition to the peak related to the TO/LO phonon, the presence of an additional peak at about 495 cm^{-1} can be observed (Prades et al. 2007). The existence of this peak has been explained by the presence of the highly twinned domains and hexagonal phase in nanowires (Kikkawa et al., 2005; Fontcuberta i Morral et al., 2007; Prades et al., 2007; Algra et al., 2008). The position of the band at 495 cm^{-1} coincides with the energy with the zone boundary of the phonon dispersion of silicon in the L point.

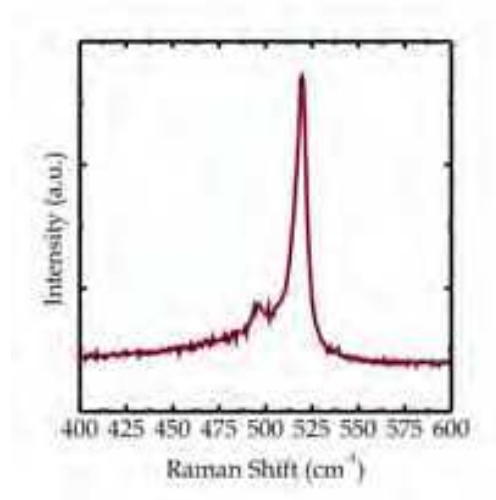


Fig. 15. Raman spectra of indium catalyzed silicon nanowires presenting high density of twins defects. Beside the TO/LO degenerate peak at 520 cm^{-1} , another peak at about 495 cm^{-1} appears.

5. Conclusions

We have presented the fundamentals for understanding Raman scattering on semiconductor nanowires. The basic physical principles of the specific phenomena related to the nanowire nature were presented. We have developed the theory and presented some experimental data on novel phenomena such as inhomogeneous heating, quantum confinement, Fano effect, the existence of surface and breathing modes and the existence of novel crystalline phases.

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This volume is intended to orient the reader in the fast developing field of semiconductor nanowires, by providing a series of self-contained monographs focusing on various nanowire-related topics. Each monograph serves as a short review of previous results in the literature and description of methods used in the field, as well as a summary of the authors recent achievements on the subject. Each report provides a brief sketch of the historical background behind, the physical and/or chemical principles underlying a specific nanowire fabrication/characterization technique, or the experimental/theoretical methods used to study a given nanowire property or device. Despite the diverse topics covered, the volume does appear as a unit. The writing is generally clear and precise, and the numerous illustrations provide an easier understanding of the phenomena described. The volume contains 20 Chapters covering altogether many (although not all) semiconductors of technological interest, starting with the IV-IV group compounds (SiC and SiGe), carrying on with the binary and ternary compounds of the III-V (GaAs, AlGaAs, GaSb, InAs, GaP, InP, and GaN) and II-VI (HgTe, HgCdTe) families, the metal oxides (CuO, ZnO, ZnCoO, tungsten oxide, and PbTiO₃), and finishing with Bi (a semimetal).

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